

CUSTOMER:	DATE:

APPROVAL SPECIFICATION

ROHS+HS
COMPLIANT

PRODUCT NAME:	SMD power inductor	,
YOUR PART NO.:		
OUR PART NO.:	MPSM201208BE2R2M-LF	00
VERSION: V1.1		.00

RECEPTION					
THE SPECIFICAT	THE SPECIFICATION HAS BEEN ACCEPTED.				
COMPANY: DATE:					
CFMD	CHKD	RCVD			

MANUFACTURING NAME

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CFMD.	CHKD.	DSGD.
Charles	Wang Yusheng	Liu Wei



CATALOG

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Component SPEC Version Record

Rev.	Effective Date	Changed Contents	Change Reasons	Approved By
1.0	2021.09.23	New released	/	Charles
1.1	2023.03.31	Add current curve	/	Charles



1. Scope

This specification applies to the MPSM201208BE series of SMD Power inductors.

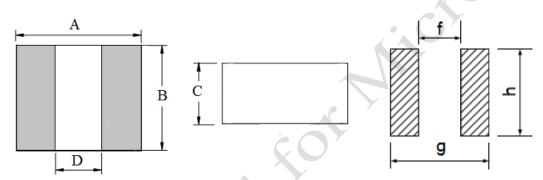
2. Product Identification

MPSM	201208	BE	<u>2R2</u>	<u>M</u> - <u>LF</u>
1	2	3	4	(5) (6)

- ① Product Symbol.
- 2 Product dimensions
- ③ Special process code.
- ④ Inductance Value: (R47:0.47 uH; 2R2: 2.2uH; 100:10uH)
- ⑤ Inductance Tolerance: (M: ±20%; N: ±30%)
- 6 Lead free product.

3. Appearance and Material

3.1 Appearance and dimensions



Note: Gray area is electrode

Recommended Land Pattern

	Dimensions in mm						
A	A B C D f g h						
2.00±0.20	1.20±0.20	0.80Max.	0.60 Typ.	0.50 Typ.	2.10 Typ.	1.30 Typ.	



4. Testing Conditions

Unless otherwise specified, the standard conditions for measurement/test as:

Ambient Temperature : 5 to 35℃ Relative Humidity: 25 to 85% RH Atmospheric Pressure: 86 to 106 kPa

If any doubt on the results, measurements/tests should be made within the following limits:

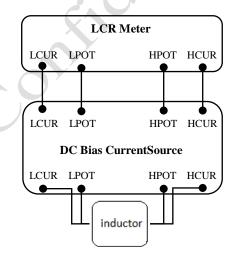
Ambient Temperature : 25±1 °C Relative Humidity: 60 to 70% RH Atmospheric Pressure: 86 to 106 kPa

5. Electrical Characteristics And Test Instruments

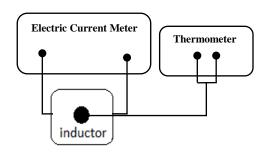
Microgate Part No.	Inductance L0 (uH)	DCR (mΩ)		Isat (A)		Irms (A)	
wherogate Fart No.	1.0MHz/1.0V	Max.	Тур.	Max.	Тур.	Max.	Тур.
MPSM201208BE2R2M-LF	2.2±20%	161	148	1.8	2.2	1.6	1.8

Test instruments and remarks

- * All test data is referenced to 25°C ambient.
- * L test by CHROMA 3302 meter or equivalent
- * DCR test by Tonghui TH2516B meter or equivalent
- * CHROMA 3302 and 1320 meter for IDC;
- * Isat: DC current (A) that will cause L0 to drop approximately 30%.
- * Irms: DC current (A) that will cause an approximate \triangle T of 40°C.
- * The withstand voltage is 20V.
- * Operating temperature: -55° C to $+125^{\circ}$ C. (Including self-heating).
- * The part temperature (ambient + temp rise) should not exceed 125°C under worse case operating conditions. Circuit design, component placement, PCB trace size and thickness, airflow and other cooling provision all affect the part temperature. Part temperature should be verified in the end application.



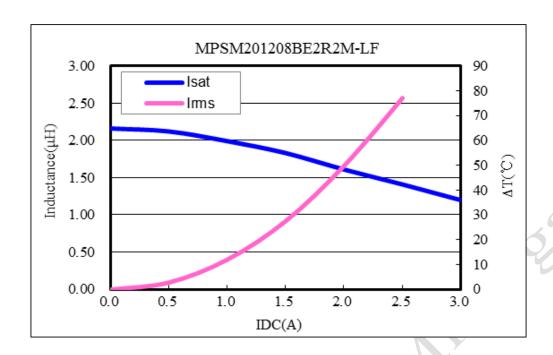




Irms test schematic diagram

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6. Reliability

No.	Item	Requirements	Test Methods and Remarks	Reference	Sample Size
1	Solderability	Terminal area must have 95% min. solder coverage.	①Temperature:245±5°C, flux 5-10 s. ②Sample immersion tin furnace 5 ±0.5s. ③Immersed and in and out of speed: 25 ±6mm/s.	AEC-Q200 (J-STD-002)	15
2	Resistance to Soldering Heat		①The peak temperature: 260+5/-0°C. ②Reflow:3times. ③Temperature curve is as below: Peak 265°C Max. Ramp Up Rate=3°C/s Max. Ramp Down Rate=6°C/s 150°C Feak 265°C Max. Ramp Down Rate=6°C/s Time 25°C to Peak =8 min Time	AEC-Q200 (MIL-STD-20 2 Method 210)	30
3	High Temperature Storage	(1) No physical	①Temperature: 125±2°C. ②Time: 1000 hours. ③Measurement at 24±4 hours after test conclusion. Temperature 125°C Room Temp. 0 1000H Time	AEC-Q200 (MIL-STD -202 Method 108)	77
4	Low Temperature Storage	damage. (2) ΔL0/L0 ≤10%	①Temperature: -55±2°C. ②Time: 1000 hours. ③Measurement at 24±4 hours after test conclusion. Room Temp. 1000H Time Temp. Low temperature Temp.	JESD22-A119	77
5	Thermal shock		①First -40°C for 15 minutes, last 125°C 15minutes as 1 cycle. Go through 300 cycles. ②Max transfer time is 20 second. ③Measurement at 24±4 hours after test conclusion. 125°C 15 min. 15 min. Temperature 15 min. 20 s (max.)	MIL-STD -202 Method 107	30



		1第 12	Sample		
No.	Item	Requirements	Test Methods and Remarks	Reference	Size
6	Humidity Resistance	(1) No physical damage. (2) $\mid \Delta L0/L0 \mid \leq 10\%$	①1000 hours, 85 °C/85% RH. ②Unpowered. ③Measurement at 24±4 hours after test conclusion. High temperature High humidity 85°C Room Temp. 1000H Time	AEC-Q200 (MIL-STD -202 Method 103)	77
7	Terminal Strength	No physical damage.	①The test samples shall be soldered to the board. ②17.64N, 60s. Radius 0.5mm Press tools Shear force	AEC-Q200 (AEC-Q200-0 06)	30
8	Board Flex	 (1) No physical damage. (2) ΔL0/L0 ≤10% 	①Part mounted on a 100mm*40mm FR4 PCB board, which is 1.6±0.2 mm thick and as a Layer-thickness 35 µm ± 10 µm. ②Bending speed is 1mm/s. ③Keeping the P.C Board 2 mm minimum for 60 seconds. Printed circuit board before testing Printed circuit board before testing Printed circuit board under test Unit: mm	AEC-Q200 (AEC-Q200-0 05)	30
9	Drop		①Height: 1 m, Free fall, 10times. ②Direction: 1 Angle, 1side, 2surface.	JESD22-B111	30
10	Vibration		①Frequency range: 10~2000Hz. ②Amplitude: 1.5mm, 5g. ③Sweep time and duration: 10~2000~10Hz for 20 minutes. ④Each four hours in X,Y,Z direction, 12 hours in total.	AEC-Q200 (MIL-STD-20 2 Method 204)	30

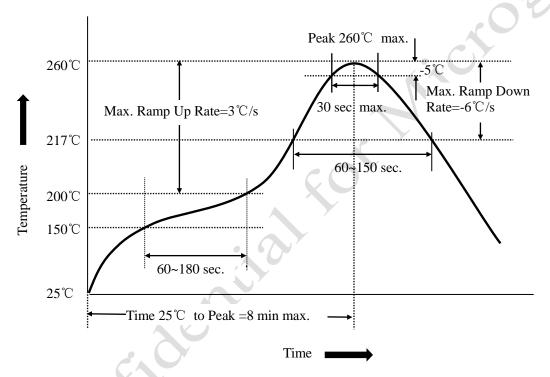


No.	Item	Requirements	Test Methods and Remarks	Reference	Sample Size
11	Loading at High Temperature	 (1) No physical damage. (2) ΔL0/L0 ≤10% 	①Temperature: 85 ±2 °C. ②Time: 1000 hours. ③Rated current. ④Measurement at 24 ±4 hours after test conclusion.	AEC-Q200 (MIL-PRF-27)	77

^{*}All above experiments items need 3 Lot., sample size is as specified in the table above.

7. Recommended Soldering Conditions

(1) Reflow soldering conditions



^{*}Above reflow soldering curve is from J-STD-020D.

(2) Iron soldering

The following conditions must be strictly followed when using a soldering iron.

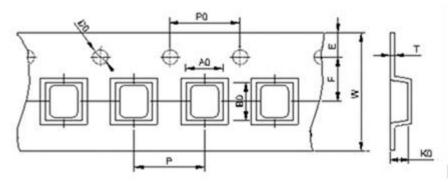
Pre-heating	150°C 1 minute
Tip temperature	350℃ max
Soldering iron output	30w max
End of soldering iron	ф1mm max
Soldering time	3 seconds max

^{*}Sample size standard is from AEC-Q200: qualification sample size requirements.



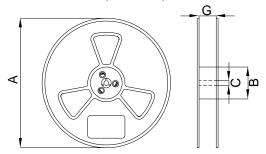
8. Packaging

(1) Dimension of tape (Unit: mm)



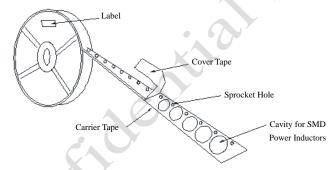
W	A0	В0	K0	E	F	P	P0	D0	T
8.0 ± 0.1	1.60±0.10	2.35±0.10	1.00±0.1	1.75 ± 0.1	3.5±0.1	4.0±0.1	4.0±0.1	1.6±0.1	0.18±0.02

(2) Dimension of reel (Unit: mm)



Symbol	Dimension
A	178±2
В	58±2
С	13.5±0.2
G	9.0±0.5

(3) Taping figure and drawing direction

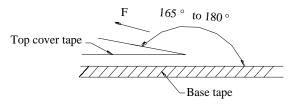


(4) Packaging quantities: 2000PCS/Reel.

(5) Peeling strength of cover tape:

The peel force of top cover tape shall be between 0.1N to 1.3N.

*the peel force standard is from EIA-481-D



Room Temp. (°C)	Room Humidity (%)	Room aim (hpa)	Peel Speed mm/min
5-35	45-85	860-1060	300

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9. Products Storage

(1) Storage period

Products which inspected in MICROGATE over 12 months ago should be examined and used, which can be confirmed with inspection No. marked on the container. Solderability should be checked if this period is exceeded.

(2) Storage conditions

Products should be storage in the warehouse on the following conditions:

Temperature: -10 ~+ 35°C

Humidity: Less than 70% relative and humidity. No rapid change on temperature and humidity.

- (3) Don't keep products in corrosive gases such as sulfur, chlorine gas or acid, or it may cause oxidization of electrode, resulting in poor solderability.
- (4) Products should be storage on the palette for the prevention of the influence from humidity, dust and so on
- (5) Products should be storage in the warehouse without heat shock, vibration, direct sunlight and so on.
- (6) Products should be storage under the airtight packaged condition.